Surface Roughness/Contour Measuring System Formtracer SV-C3200/4500 Series



Bulletin No. 2073

Dual-purpose measurement and powerful analysis of surface roughness and contour combined with high accuracy, high drive speed and simplified CNC measurement



Hybrid measuring instrument for surface roughness and contour measurement

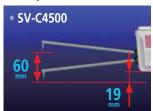
Contour Measuring Functions

Detector with new arm design

Expands measurement range while reducing workpiece interference Mitutoyo's newly designed detector arm lowers workpiece interference while expanding the measurement range in the Z1 axis (detector).

• When using the SPH-71 one-sided cut stylus





Detector measurement range expanded by 10 mm

One-touch arm attachment

(Patent pending in Japan)

The arm mount uses a magnetic joint for quick and easy arm replacement. The mount also includes a safety mechanism.

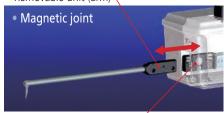
• **SV-C4100** (Conventional product)







Removable unit (arm)



Removable unit (detector) /

New function specified for 4500 Series

Continuous top-bottom measurement function

Upper and lower surfaces can be measured continuously by using Mitutoyo's double-sided conical stylus.

This continuous measurement data can be used to facilitate analysis of features that were difficult to measure before, such as the effective diameter of an internal screw-thread.

Lower direction measurement (Bottom surface)

Upper direction measurement (Top surface)









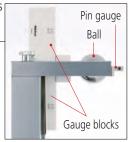
Continuous top-bottom measurement allows hassle-free one-step calibration

(Patent pending in Japan)

The one-step calibration kit supplied with the SV-C4500 Series has been upgraded to enable easy calibration of the double-ended conical stylus featuring a contact on both the top and the bottom. Precise work such as calibrating the Z1-axis gain, symmetry, and stylus radius can now be carried out in a single operation.

Calibration kit for SV-C4500 Series





Variable measuring force function

The measuring force can be varied in 5 steps by using the software provided (**FORMTRACEPAK**), eliminating the need to adjust

the measuring force by switching weights or through positional adjustment.

The SV-C4500 Series can also maintain the specified measuring force even when tilted.







Surface Roughness Measuring Functions

Supporting International Standards

Compliant with JIS '82/'94/'01, ISO, ANSI, DIN, VDA, and other international surface roughness standards.

We offer a product lineup of surface roughness detectors with different measuring forces

Standard detectors can be selected (as listed below) to conform to the international standard required. 0.75 mN (tip angle 60° ; tip radius $2 \mu m$)

Reduction of measuring time and operator's fatigue

In addition to high speed movement of main unit, reduction of setting time and operator's fatigue can be achieved by using Auto-leveling Table (option), which allows automatic leveling for a measuring face.

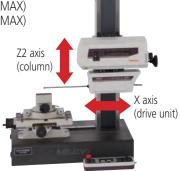
Common specifications

Fast traverse improves measurement efficiency

4mN (tip angle 90°; tip radius 5µm)

X axis (drive unit): 80mm/s (MAX) Z2 axis (column): 30mm/s (MAX)

The total measurement time can be shortened by speeding up the traverse movements.



Remote-control unit enables safe, easy & fast measurement

The remote-control unit lets you move quickly from positioning to measurement. The unit also features an emergency stop switch and speed control knob for added safety while the machine is moving at high speeds.



Auto stop feature assures safety even during high-speed movement

The detector includes a safety mechanism (auto stop upon collision) to assure measurement safety even during high-speed movement. If the arm is removed or shifts during measurement, the safety mechanism is triggered and stops the machine.

Direction of collision that may cause the safety device to be triggered



Incorporation of an ABS scale in the Z2 axis eliminates

the need for wearisome origin point re-setting conventionally required for every step of repeated measurements over stepped or multiple sections.

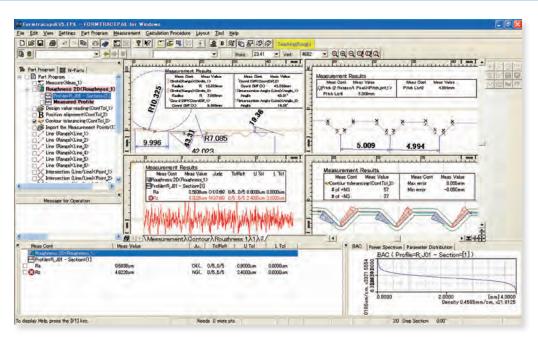


All detector and drive unit cables are housed inside the main unit to eliminate any risk of abrasion and guarantee trouble

free, high-speed operation.



Contour Analysis Software: FORMTRACEPAK

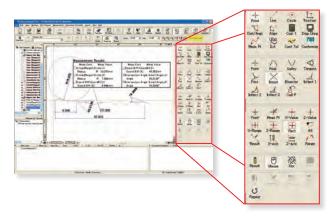


Contour Measuring

Contour analysis function

Upper and lower surfaces can be measured continuously by using Mitutoyo's double-sided conical stylus.

This continuous measurement data can be used to facilitate analysis of features that were difficult to measure before, such as the effective diameter of an internal screw-thread.



- Contour-tolerancing function as a standard feature
- Design value generation function
- Data combination function
- Simple pitch calculation function

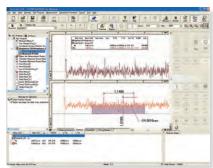


Surface Roughness Measuring

Surface Roughness analysis function

FORMTRACEPAK can perform surface roughness analyses that conform to various standards such as ISO, JIS ANSI, and VDA. For comparing the measurement values with the tolerance limits, you can use the 16% rule or the maximum value rule. Furthermore, since FORMTRACEPAK comes with parameter calculation functions as well as a rich set of graphic analysis functions, it can be widely utilized for everything from routine quality control to R&D

applications. It also includes many other functions, such as the function for eliminating (compensating) shapes, such as slopes and R-surface, and a data deletion function.



- Microscopic contour analysis function
- Simple input using drawing symbols
- Multiple-point measurement function
- Analysis function using multiple-point measurement
- Reference length dialog box
- Analysis condition modification with a preview function
- R-surface automatic measurement function

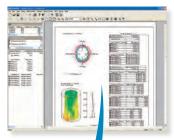
Note: Please refer to the FORMTRACEPAK catalog (E4386) for more details.

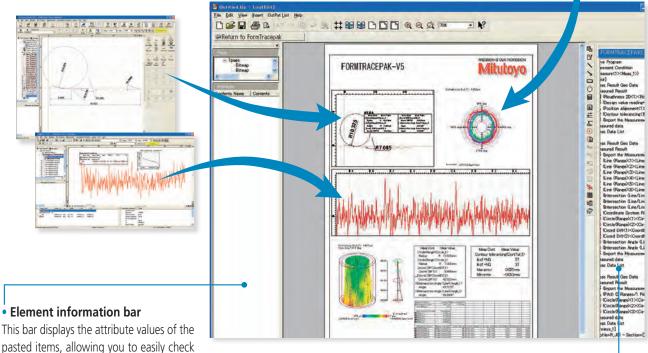


Integrated layout

You can use simple operations to lay out graphics obtained from measurements as well as measurement results for surface roughness, contour, and roundness on a single page. Furthermore, since the program now allows you to specify a saved file and paste it, you can easily paste results from multiple files.

Note: the optional ROUNDPAK roundness/cylindricity analysis program is required. (Ver. 7 or higher)





System layout printing

data files.

the contents of the pasted measurement

By simply selecting the items to be output, you can automatically lay out the page to be printed.

Use this feature when you wish to simplify the printing task.



• Element insertion bar

Using the mouse to drag and drop the analysis content displayed in the element insertion bar, you can paste it onto the layout. From the contour analysis result, you can also select the analysis result for a circle or line alone and paste it in position.

• Saving the result as a web page

Since you can save the result in html or mhtml format, which can be displayed using Internet Explorer or Microsoft Word, you can check the result even on a PC in which no layout-editing program is installed.

Report creation function

You can freely assemble measurement results/conditions/graphics as well as comments/circles/lines/arrows, and print them out in a measurement result report. Furthermore, since you can paste bitmap files, you can also add a workpiece image or company logo to the layout. You can also save the created layout and use it again later for similar measurements.

Optional Accessories for Automatic Measurement

Y-axis table: 178-097

Enables efficient, automatic measurement of multiple aligned workpieces and multiple points on a single measurement surface.



Travel range	200mm
Resolution	0.05µm
Positioning accuracy	±3µm
Drive speed	Max. 80mm/s
Maximum load	50kg
Mass	28kg



Rotary Table θ 1-axis table: 12AAD975*

For efficient measurement in the axial/transverse directions. When measuring a cylindrical workpiece, automatic alignment can be performed in combination with the Y-axis table.

 $\star\theta$ 1-axis mounting plate (12AAE630) is required when directly installing on the base of the SV-C3200/4500.



Displacement	360°
Resolution	0.004°
Maximum load	12kg
Rotational speed	Max. 10°/s
Mass	7kg



Rotary Table θ 2-axis unit: 178-078*

You can measure multiple points on a cylindrical workiece and automate front/rear-side measurement.

*02 -axis mounting plate (12AAE718) is required when directly installing on the base of the SV-C3200/4500.



Displacement	360°
Resolution	0.0072°
Maximum load (loading moment)	4kg (343 N•cm or less)
Rotational speed	Max. 18°/s
Mass	5kg



Centering chuck (ring operated): 211-032

This chuck is useful when measuring small workpieces. You can easily clamp them with its knurled ring.



	Clamping range	Jaws normal	OD: ø1 - ø36mm	
		Jaws normal	ID: ø16 - ø69mm	
		Jaws reversed	OD: ø25 - ø79mm	
	Dimensions		ø118x41mm	
	Mass		1.2kg	

Micro-chuck: 211-031

This chuck is suitable for clamping extra-small diameter workpieces (ø1 mm or less), which cannot be retained with the centering chuck.



Clamping range	OD: ø0.1 - ø1.5mm
Dimensions	ø118x48.5mm
Mass	0.6kg

Auto-leveling table: 178-087

This is a stage that performs fully automatic leveling as measurement starts, freeing the user from this troublesome operation. Fully automatic leveling can be done quickly by anyone. In addition, the operation is easy and reliable.



Inclination adjustment angle	±2°
Maximum load	7kg
Table dimensions	130 x 100mm
Mass	3.5kg



Options

3-axis Adjustment Table: 178-047

This table helps make the alignment adjustments required when measuring cylindrical surfaces. The corrections for the pitch angle and the swivel angle are determined from a preliminary measurement and the Digimatic micrometers are adjusted accordingly. A flat-surfaced work-





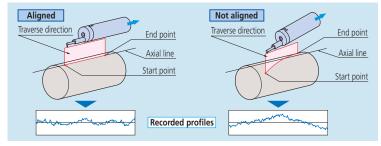
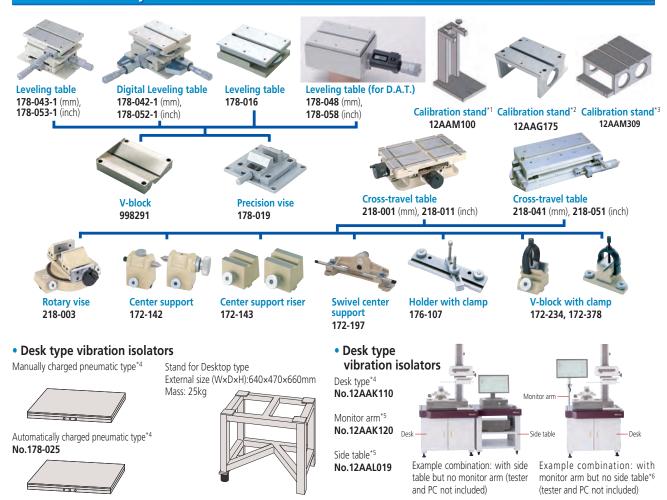


Table and fixture systems



- *1 Required for calibrating upward measurement of SV-C3200 series.
- *2 Required for calibrating in bulk by mounting straight arm/small-hole stylus arm without using cross-travel table and Y-axis table.
- *3 Required for calibrating in bulk by mounting straight arm/eccentric arm/small-hole stylus arm without using cross-travel table and Y-axis table.
- *4 For models with a product code that ends in S4, S8, H4, or H8. Please contact us directly if you require units for models with a product code that ends in W4 or W8 (large base models).
- *5 Used together with vibration isolator (No.12AAK110).
- *6 User to provide a printer rack.

Detectors / Styli (For Surface Roughness Measuring)

Detectors 11.5 10 60 14 ϕ 14 3.1 +8 Skidles<u>s nosepiece</u> Detector (12AAB355)

Order No.	Measuring force	
178-396-2	0.75mN	ISO-1997 and JIS-2001 compliant detectors
178-397-2	4mN	Detectors that comply with previous standards, for general use, etc.

Extension rods

• 12AAG202 Extension rod 50mm



12AAG203 Extension rod 100mm



* No more than one extension rod can be connected.

Styli

44.7 Standard stylus 37.7 \$1.2 \$1.2 Detail-A 90

12AAE882 (1µm) *1 **12AAE924** (1µm) 12AAC731 (2µm) *1 12AAB403 (5µm) 12AAB415 (10µm) 12AAE883 (250µm) *4 (): Tip radius

Double-length for deep hole *2 12AAE898 (2µm) *1 **12AAE914** (5µm) 87.7 (): Tip radius

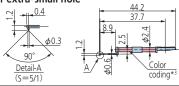
For small hole 44.4 37.7 φ2.4 Detail-A (S=5/1) ∠Color coding*3

12AAC732 (2µm) *1 12AAB404 (5µm) 12AAB416 (10µm) (): Tip radius

For small hole/Double-length for deep hole *2 87.7 $\phi 0.6$ φ2.4 Detail-A

12AAE892 (2µm) *1 12AAE908 (5µm) (): Tip radius

For extra-small hole

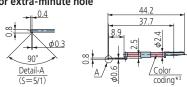


12AAC733 (2µm) *1 **12AAB405** (5µm) 12AAB417 (10µm) (): Tip radius

For small hole *2 *4 87.7 Ball **φ**1.6

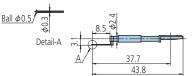
12AAE884 (φ1.6mm) (): Tip radius

For extra-minute hole



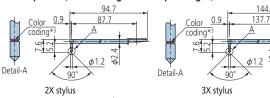
12AAC734 (2µm) *1 12AAB406 (5µm) 12AAB418 (10µm) (): Tip radius

For ultra-small hole *4



12AAJ662 (φ0.5mm) (): Tip radius

For deep hole (double-length and triple-length) *2



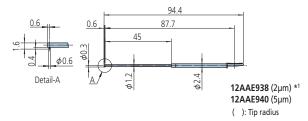
12AAC740 (2µm) *1 12AAB413 (5µm) 12AAB425 (10µm) (): Tip radius

12AAC741 (2µm) *1 12AAB414 (5µm) 12AAB426 (10µm)

(): Tip radius

144.7

For small slotted hole *2



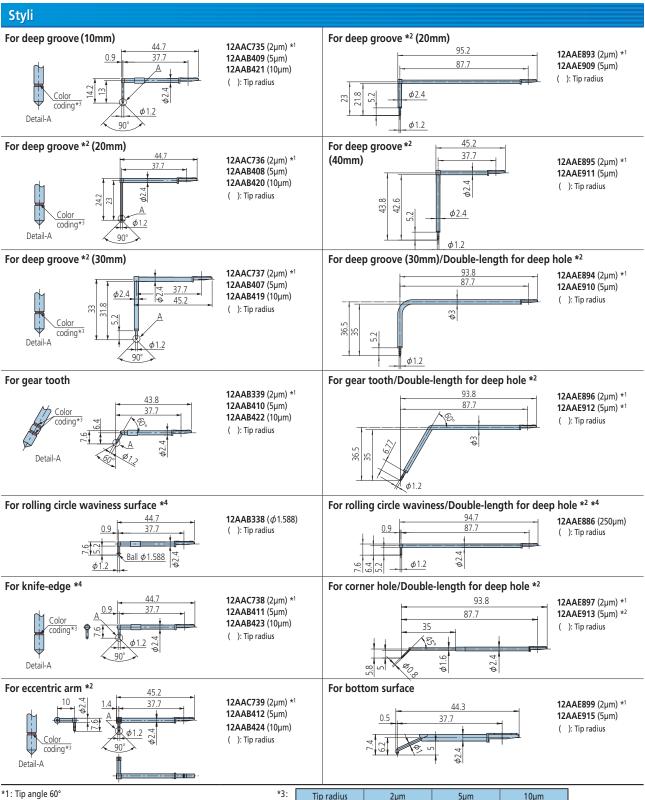
Tip radius 1µm 2µm 5µm 10µm 250µm Yellow No notch or color



^{*4:} Used for calibration, a standard step gauge (No.178-611 (mm), No.178-612 (inch), option) is also required

^{*1:} Tip angle 60°

^{*2:} For downward-facing measurement only.



Customized special interchageable styli are available on request, Please contact any Mitutoyo office for more information.

*2: For downward-facing measurement only.

^{*3:} Tip radius 2 µm 5 µm 10 µm

Color coding Black No color Yellow

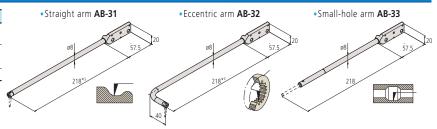
^{*4:} Used for calibration, a standard step gauge (No.178-611 (mm), No.178-612 (mm), option) is also required

Arms / Styli (For Contour Measuring)

Arms

Description	Description Arm No.		Applicable stylus No.		
Straight arm	AB-31*1	12AAM101	SPH-5*, 6*, 7*, 8*, 9*, SPHW* ² -56,66,76		
Eccentric arm	AB-32	12AAM102	SPH-5*, 6*, 7*, 8*, 9*, SPHW* ² -56,66,76		
Small-hole arm	AB-33	12AAM103	SPH-41, 42, 43		

- *1 Standard accessory *2 Stylus for SV-C4500 series
- *3 One-sided cut stylus SPH-71 (standard accessory) mounting



Styli

	r		1	
Stylus name	Stylus No.	Parts No.	Application arm No.	H (mm)
Double-sided	SPHW-56	12AAM095*2	AB-31, AB-32	20
conical stylus *1	SPHW-66	12AAM096	AB-31, AB-32	32
corrical stylus	SPHW-76	12AAM097	AB-31, AB-32	48
	SPH-51	354882	AB-31, AB-32	6
One-sided cut	SPH-61	354883	AB-31, AB-32	12
stylus	SPH-71	354884 *2*3	AB-31, AB-32	20
stylus	SPH-81	354885	AB-31, AB-32	30
	SPH-91	354886	AB-31, AB-32	42
	SPH-52	354887	AB-31, AB-32	6
Intersecting cut	SPH-62	354888	AB-31, AB-32	12
stylus	SPH-72	354889	AB-31, AB-32	20
stylus	SPH-82	354890	AB-31, AB-32	30
	SPH-92	354891	AB-31, AB-32	42
	SPH-53	354892	AB-31, AB-32	6
Cone stylus	SPH-63	354893	AB-31, AB-32	12
Tip angle 30°	SPH-73	354894	AB-31, AB-32	20
Sapphire tipped	SPH-83	354895	AB-31, AB-32	30
	SPH-93	354896	AB-31, AB-32	42
	SPH-56	12AAA566	AB-31, AB-32	6
Cone stylus	SPH-66	12AAA567	AB-31, AB-32	12
Tip angle 30°	SPH-76	12AAA568	AB-31, AB-32	20
Carbide-tipped	SPH-86	12AAA569	AB-31, AB-32	30
	SPH-96	12AAA570	AB-31, AB-32	42
	SPH-57	12AAE865	AB-31, AB-32	6
Cone stylus	SPH-67	12AAE866	AB-31, AB-32	12
Tip angle 20°	SPH-77	12AAE867	AB-31, AB-32	20
Carbide-tipped	SPH-87	12AAE868	AB-31, AB-32	30
	SPH-97	12AAE869	AB-31, AB-32	42
Cone stylus Tip angle 50° Diamond tipped	SPH-79	355129	AB-31, AB-32	20
	SPH-54	354897	AB-31, AB-32	6
	SPH-64	354898	AB-31, AB-32	12
Knife edge stylus	SPH-74	354899	AB-31, AB-32	20
	SPH-84	354900	AB-31, AB-32	30
	SPH-94	354901	AB-31, AB-32	42
	SPH-55	354902	AB-31, AB-32	6
	SPH-65	354903	AB-31, AB-32	12
Ball stylus	SPH-75	354904	AB-31, AB-32	20
	SPH-85	354905	AB-31, AB-32	30
	SPH-95	354906	AB-31, AB-32	42
	SPH-41	12AAM104	AB-33	2
Small hole stylus*4	SPH-42	12AAM105	AB-33	4
Sman note stylus	SPH-43	12AAM106	AB-33	6.5



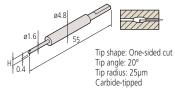
Tip angle: 30° Tip radius: 25µm Carbide-tipped

Double-sided conical stylus Cone stylus



Tip angle: 30° (SPH-79: 50°) Tip radius: 25µm Sapphire, Carbide-tipped (SPH-79:Diamond tipped)

Small hole stylus SPH-41



One-sided cut stylus





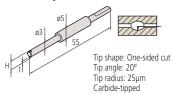
Tip angle: 12° Tip radius: 25µm Carbide-tipped

Cone stylus



Tip angle: 20° Tip radius: 25µm Carbide-tipped

Small hole stylus SPH-42



Intersecting cut stylus





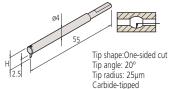
Tip angle: 20° Tip radius: 25µm Carbide-tipped

Knife edge stylus



Tip angle: 20° Edge width: 3mm Tip radius: 25µm Carbide-tipped

Small hole stylus SPH-43



Ball stylus





Ball dia: 1mm Carbide-tipped

*4 Styli SPH-21, 22, and 23 for **SV-C3100/4100 series** are not available.

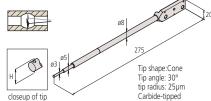
Arm stylus (comprising an arm and stylus)					
Arm stylus name	Stylus No.	Parts No.	H (mm)		
	SPHW-31	12AAM108	2.4		
Double-sided small hole arm stylus	SPHW-32	12AAM109	5		
	SPHW-33	12AAM110	9		

^{*5} Arm Stylus for SV-C4500 series

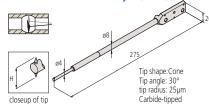
Stylus for SV-C4500 series *2 Standard accessory of **SV-C4500 series** *3 Standard accessory of **SV-C3200 series**

Double-sided small hole arm stylus SPHW-31 Tip shape:Cone Tip angle: 30° tip radius: 25µm

Double-sided small hole arm stylus SPHW-32



Double-sided small hole arm stylus SPHW-33

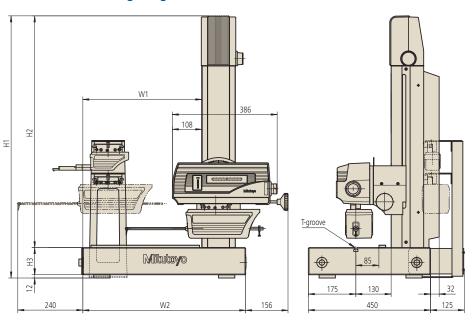


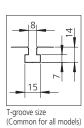


Dimensions

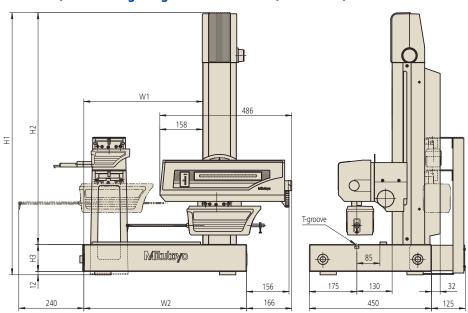
X-axis (drive unit) measuring range: 100mm TYPE (S4/H4/W4)

Unit: mm





X-axis (drive unit) measuring range: 200mm TYPE (S8/H8/W8)



X-axis (drive unit)	Models		H1	H2	Н3	W1	W2
Measuring range	3200 Series	4500 Series	(mm)	(mm)	(mm)	(mm)	(mm)
	SV-C3200S4	SV-C4500S4	966	854	100	438	600
100mm	SV-C3200H4	SV-C4500H4	1166	1054	100	438	600
	SV-C3200W4	SV-C4500W4	1176	1054	110	838	1000
	SV-C3200S8	SV-C4500S8	966	854	100	438	600
200mm	SV-C3200H8	SV-C4500H8	1166	1054	100	438	600
	SV-C3200W8	SV-C4500W8	1176	1054	110	838	1000

Specifications

SV-C3200S4

SV-C3200H4

Model No.		(525-491A-1)	(525-492A-1)	(525-493A-1)	(525-496A-1)	(525-49/A-1)	(525-498A-1)
(Order No	.)	SV-C4500S4 (525-451A-1)	SV-C4500H4 (525-452A-1)	SV-C4500W4 (525-453A-1)	SV-C4500S8 (525-456A-1)	SV-C4500H8 (525-457A-1)	SV-C4500W8 (525-458A-1)
Specificati	ons for Surface Roughr	ness Measurement		,	,		
Measuring	X axis (drive unit)		100mm 20				
range	Z1 axis (detector unit)			800µm / 8	0μm / 8μm		
Straightnes	S	(0.05+0.0	001L) µm L = Drive ler	ngth (mm)		0.5µm / 200mm	
Resolution	Z1 axis (detector unit)		0.0	1μm (800μm) , 0.001μr	n (80µm) , 0.0001µm (8	μm)	
Measuring	force			0.75mN	l or 4mN		
Stylus tip			60°, 2μmR (Me	asuring force: 0.75mN)	or 90°, 5µmR (Measur	ing force: 4mN)	
Conformab	le standards			JIS1982/JIS1994/JIS20	001/ISO1997/ANSI/VD <i>A</i>	1	
Parameters		Pa, Pq, Psk, Pku, Pp, Pv, Pz, Pt, Pc, PSm, PΔq, Pm(rC), Pmr, Pδc, Ra, Rq, Rsk, Rku, Rp, Rv, Rz, Rt, Rc, RSm, RΔq, Rm(rC) Rmr, Rc, Wa, Wq, Wsk, Wku, Wp, Wv, Wz, Wt, Wc, WSm, WΔq, Wm(rC) Wmr, Wδc, Rk, Rpk, Rvk, Mr1, Mr2, A1, A2, Rx, AR, R, Wx, AW, W, Wte, Ry, RyDIN, RzDIN, R3y, R3z, S, HSC, Lo, Ir, Δa, λa, λq, Vo, Htp, NR, NCRX, CPM, SR, SAR, NW, SW, SAW					
Assessed profiles		Primary Profile, Roughness profile, Envelope residual curve, Filtered waviness curve, Band pass waviness curve, Waviness curve, Rolling circle waviness curve, Roughness motif, Waviness motif, DIN4776 curve					
Graphs		Amplitude distribution graphs, BAC1, BAC2, Power spectrum curve, Auto correlation curve Inclination angle distribution curve, Peak point height distribution curve, Parameter distribution curve					
Data compe	ensation	Tilt compensation, R-surface compensation, Ellipse Compensation, Parabola compensation, Hyperbolic compensation, Polynomial compensation, Conic automatic compensation, Polynomial automatic compensation					
Filters			Gaussian filter, 2CRPC75, 2CRPC50, 2CR75, 2CR50, Robust spline filter				
Specificati	ons for Contour Measu	ırement					
Measuring	X axis (drive unit)		100mm			200mm	
range	Z1 axis (detector unit)		60mm (±30mm in horizontal situation)				
Straightnes (when the	s X axis is horizontal)		0.8μm / 100mm		2μm / 200mm		
	X axis (drive unit)	± (0.8+0	01L) μm L = Drive len	gth (mm)	± (0.8+0	.02L) μm L = Drive len	gth (mm)
Accuracy	Z1 axis (detector unit)	SV-C3200 series: ± (1.6+ 2H /100) μm, SV-C4500 series: ± (0.8+ 2H /100) μm H = Measurement height from the horizontal position (mm)					

SV-C3200W4

SV-C3200S8

SV-C3200H8

SV-C3200W4

Measuring face direction
Common Specifications

Measuring force

X axis (drive unit)

Z2 axis (column)

Resolution Z1 axis (detector unit)

Commi	ii specifications				
Z2-axis (column) travel range		300mm	500mm	300mm	500mm
X-axis inclination angle		±45°			
Drive speed	X axis	0~80mm/s and manual operation			
	Z2 axis (column)	0~30mm/s and manual operation			
Measuring speed		0.02~5mm/s			

Note: All information regarding our products, and in particular the illustrations, drawings, dimensional and performance data contained in this printed matter as well as other technical data are to be regarded as approximate average values. We therefore reserve the right to make changes to the corresponding designs. The stated standards, similar technical regulations, descriptions and illustrations of the products were valid at the time of printing. In addition, the latest applicable version of our General Trading Conditions will apply. Only quotations submitted by ourselves may be regarded as definitive.

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Coordinate Measuring Machines
Vision Measuring Systems
Form Measurement
Optical Measuring
Sensor Systems
Test Equipment and Seismometers
Digital Scale and DRO Systems
Small Tool Instruments and Data Management

 $0.05 \mu m$

SV-C3200 series: 0.04 µm, SV-C4500 series: 0.02 µm

1µm

SV-C3200 series: 30mN, SV-C4500 series:10, 20, 30, 40, 50mN (Setting measuring force FORMTRACEPAK)

SV-C3200 series: Both upward and downward, SV-C4500 series: Both upward and downward (direction switch from FORMTRACEPAK)

Mitutoyo America Corporation

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